F/G. 1

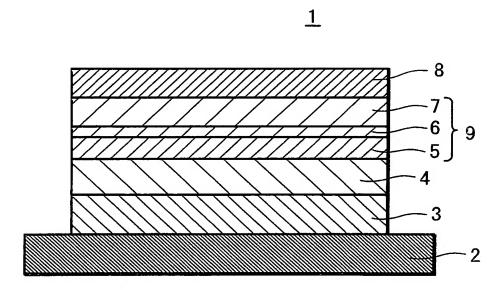
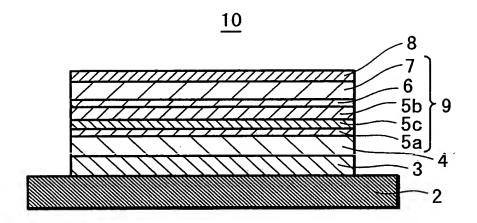
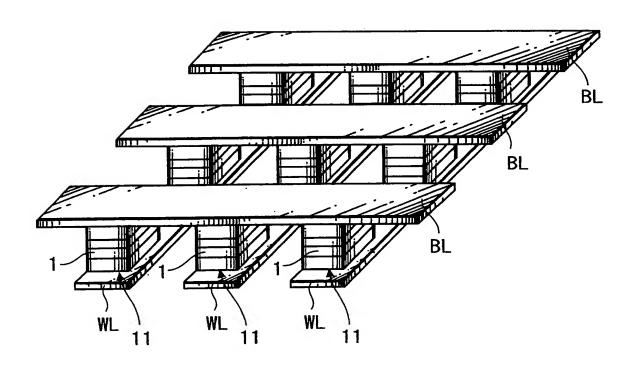


FIG. 2A TMR[%] -75 -50 -25 H[0e] FIG. 2B TMR[%] -75 -50 -25 H[0e] FIG. 2C TMR[%] -75 -50 -25 H[Oe]

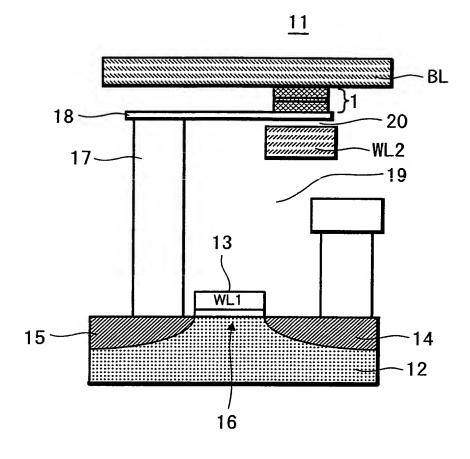
F1G. 3



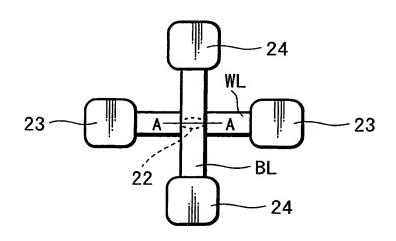
F/G. 4



F/G. 5



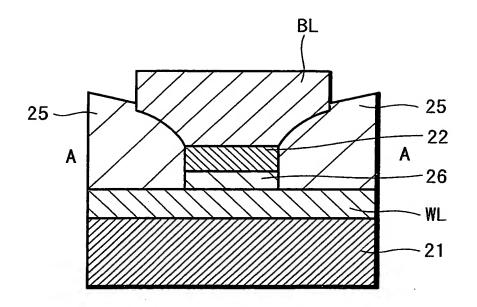
F/G. 6



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F/G. 7



## DESCRIPTION OF REFERENCE NUMERALS

- 1, 10, 22 ... tunnel magnetoresistive devices
- (TMR devices)
- 2, 21 ... substrate
- 3 ... underlayer
- 4 ... antiferromagnetic layer
- 5 ... magnetization fixed layer
- 5a ... first magnetization fixed layer
- 5b ... second magnetization fixed layer (reference layer)
- 5c ... nonmagnetic conductive layer
- 6 ... tunnel barrier layer
- 7 ... magnetization free layer
- 9 ... ferromagnetic tunnel junction
- 11 ... memory cell
- 23, 24 ... pads
- WL, WL1, WL2 ... word lines
- BL ... bit line